

<b>Notice of References Cited</b>	Application/Control No. 09/771,464	Applicant(s)/Pat nt Under Reexamination VANTTINEN ET AL.	
	Examiner Hanh Nguyen	Art Unit 2616	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,801,782 B2	10-2004	McCrary et al.	455/517
*	B	US-6,330,454 B1	12-2001	Verdonk, Timothy C.	455/456.2
*	C	US-6,285,667 B1	09-2001	Willars et al.	370/329
*	D	US-6,748,320 B2	06-2004	Jones, M. Kelly	701/201
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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